

SP490E/491E

Enhanced Full Duplex RS-485 Transceivers

FEATURES

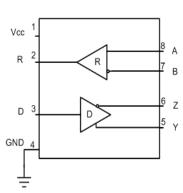
- +5V Only
- Low Power BiCMOS
- Driver/Receiver Enable (SP491E)
- RS-485 and RS-422 Drivers/Receivers
- Pin Compatible with LTC490 and SN75179 (SP490E)
- Pin Compatible with LTC491 and SN75180 (SP491E)
- · Improved ESD Specifications:
 - ±15kV Human Body Model
 - ±15kV IEC61000-4-2 Air Discharge
 - ±8kV IEC61000-4-2 Contact Discharge

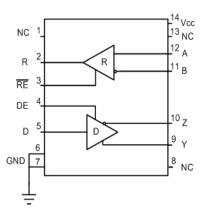
Now Available in Lead Free Packaging

DESCRIPTION

The **SP490E** is a low power differential line driver/receiver meeting RS-485 and RS-422 standards up to 10Mbps. The **SP491E** is identical to the **SP490E** with the addition of driver and receiver tri-state enable lines. Both products feature ±200mV receiver input sensitivity, over wide common mode range. The **SP490E** is available in 8-pin plastic DIP and 8-pin NSOIC packages for operation over the commercial and industrial temperature ranges. The **SP491E** is available in 14-pin DIP and 14-pin NSOIC packages for operation over the commercial and industrial temperature ranges.

BLOCK DIAGRAMS





SP490E SP491E

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ABSOLUTE MAXIMUM RATINGSThese are stress ratings only and functional operation of the device at these ratings or any other above those indicated in the operation sections of the specifications below is not implied. Exposure to absolute maximum rating conditions for extended periods of time may affect reliability.

V	+7V
V _{cc} Input Voltages	
Drivers	0.5V to (V _{cc} +0.5V)
Receivers	
Output Voltages	
Drivers	±14V
Receivers	0.5V to (V _{co} +0.5V)
Storage Temperature	65°C to +150°
Power Dissipation	1000mW

ELECTRICAL CHARACTERISTICS

 $\rm T_{MIN}$ to $\rm T_{MAX}$ and $\rm V_{CC}$ = 5V \pm 5% unless otherwise noted.

PARAMETERS	MIN.	TYP.	MAX.	UNITS	CONDITIONS
SP490E DRIVER					
DC Characteristics Differential Output Voltage Differential Output Voltage	GND 2		V _{cc}	Volts Volts	Unloaded; $R = \infty$; see figure 1 With Load; $R = 50\Omega$; (RS422); see figure 1
Differential Output Voltage	1.5		V _{cc}	Volts	With Load; R = 27Ω ; (RS485); see figure 1
Change in Magnitude of Driver Differential Output Voltage for Complimentary States Driver Common-Mode			0.2	Volts	R = 27Ω or R = 50Ω ; see figure 1
Output Voltage Input High Voltage	2.0		3	Volts Volts	R = 27Ω or R = 50Ω; see figure 1 Applies to D
Input Low Voltage Input Current Driver Short-Circuit Current			0.8 ±10	Volts μΑ	Applies to D Applies to D
V _{OUT} = HIGH V _{OUT} = LOW			250 250	mA mA	-7V ≤ V _o ≤ +12V -7V ≤ V _o ≤ +12V
SP490E DRIVER					
AC Characteristics Maximum Data Rate Driver Input to Output	10	30	60	Mbps ns	$t_{\rm PLH}$; $R_{\rm DIFF}$ = 54 Ω , $C_{\rm L_1}$ = $C_{\rm L_2}$ = 100pF; see figures 3 and 5
Driver Input to Output		30	60	ns	t_{PHL} ; $R_{DIFF} = 54\Omega$, $C_{L1} = C_{L2} = 100pF$; see figures 3 and 5
Driver Skew		5		ns	see figures 3 and 5,
Driver Rise or Fall Time		15	40	ns	$\begin{array}{l} t_{\rm SKEW} = \ t_{\rm DPLH} - t_{\rm DPHL} \\ {\rm From}\ 10\%\ to\ 90\%; \ {\rm R}_{\rm DIFF} = 54\Omega, \\ {\rm C}_{\rm L1} = {\rm C}_{\rm L2} = 100 {\rm pF}; \ see\ figures\ 3\ and\ 5 \end{array}$
SP490E RECEIVER					
DC Characteristics Differential Input Threshold Input Hysteresis Output Voltage High Output Voltage Low Input Resistance Input Current (A, B); V _{IN} = 12V Input Current (A, B); V _{IN} = -7V	-0.2 3.5 12	70 15	+0.2 0.4 ±1.0 -0.8	Volts mV Volts Volts kΩ mA mA	$ \begin{array}{l} -7V \leq V_{CM} \leq 12V \\ V_{CM} = 0V \\ I_{O} = -4mA, \ V_{ID} = +200mV \\ I_{O} = +4mA, \ V_{ID} = -200mV \\ -7V \leq V_{CM} \leq 12V \\ V_{IN} = 12V \\ V_{IN} = -7V \end{array} $
Short-Circuit Current	3D	d, Fremont	85	mA	w≤v₀≤vcc m/Exar/

 $\rm T_{_{MIN}}$ to $\rm T_{_{MAX}}$ and $\rm V_{_{CC}}$ = 5V \pm 5% unless otherwise noted.

PARAMETERS	MIN.	TYP.	MAX.	UNITS	CONDITIONS
SP490E RECEIVER					
AC Characteristics					
Maximum Data Rate	10			Mbps	
Receiver Input to Output	20	45	100	ns	t : R = 54Ω.
The second of th					t_{PLH} ; $R_{DIFF} = 54\Omega$, $C_{L1} = C_{L2} = 100pF$; Figures 3 & 7
Receiver Input to Output	20	45	100	ns	t R = 540
Troceros imparto d'alpar					C = C = 100pF: Figures 3 & 7
Diff. Receiver Skew It _{PLH} -t _{PHI} I		13		ns	$ \begin{array}{l} t_{\rm PHL}^{\rm L1}; R_{\rm DIF}^{\rm L2} = 54\Omega, \\ C_{\rm L1}^{\rm E} = C_{\rm L2}^{\rm E} = 100 {\rm pF}; \ \emph{Figures 3 \& 7} \\ R_{\rm DIFF}^{\rm E} = 54\Omega; C_{\rm L1}^{\rm E} = C_{\rm L2}^{\rm E} = 100 {\rm pF}; \end{array} $
PLH PHL					Figures 3 & 7
					. rguros o u r
DOWED DECLUBEMENTS					
POWER REQUIREMENTS	+4.75		+5.25	Volts	
Supply Voltage	74.75	900	+5.25		
Supply Current		900		μA	
ENVIRONMENTAL AND					
ENVIRONMENTAL AND MECHANICAL					
Operating Temperature			. 70	00	
Commercial (_C_)	0		+70	°C	
Industrial (_E_)	-40		+85	°C	
Storage Temperature	-65		+150	°C	
Package					
Plastic DIP (_P)					
NSOIC (_N)					

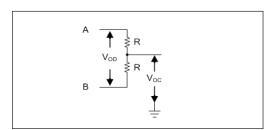
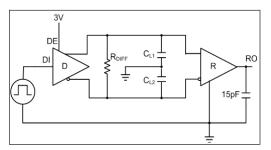


Figure 1. Driver DC Test Load Circuit



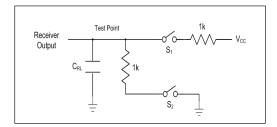


Figure 2. Receiver Timing Test Load Circuit

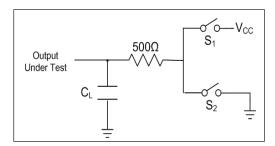


Figure 3. Driver/Receiver Timit g Test Circuit Figure 4. Driver Timing Test Load #2 Circuit

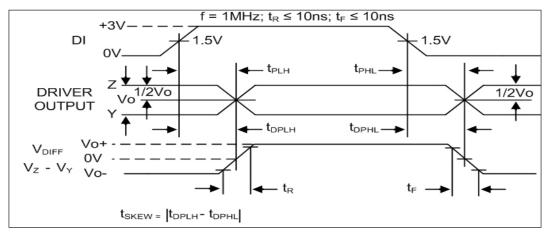


Figure 5. Driver Propagation Delays

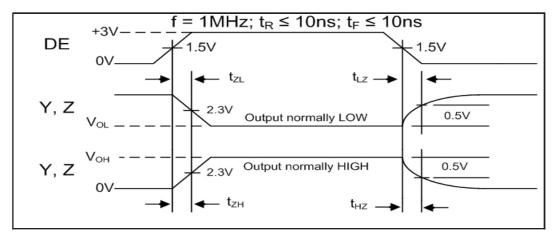


Figure 6. Driver Enable and Disable Times

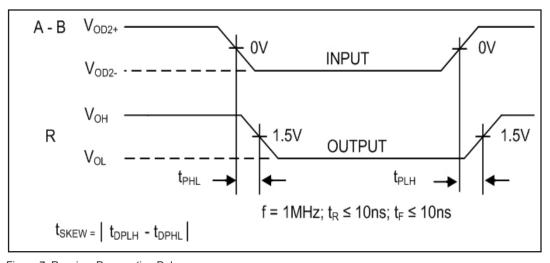


Figure 7. Receiver Propagation Delays

Bar Corporation 40720 Kato Road, Premont CA, 94550* (210008-707), www.exar.com

S-4500-451E 100 05271

ABSOLUTE MAXIMUM RATINGS
These are stress ratings only and functional operation of the device at these ratings or any other above those indicated in the operation sections of the specifications below is not implied. Exposure to absolute maximum rating conditions for extended periods of time may affect reliability.

V _{cc}	+7V
Input Voltages	
Logic	0.5V to (V _{cc} +0.5V)
Drivers	0.5V to (Vcc+0.5V)
Receivers	±14V
Output Voltages	
	0.5V to (V _{cc} +0.5V)
	±14Ý
Receivers	0.5V to (V _{cc} +0.5V)
Storage Temperature	
Power Dissipation	

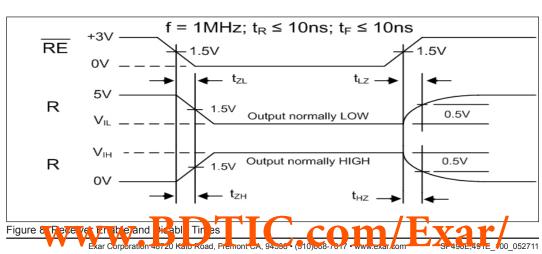
ELECTRICAL CHARACTERISTICS

T to T and V = 5V + 5% unless otherwise noted

PARAMETERS	MIN.	TYP.	MAX.	UNITS	CONDITIONS
SP491E DRIVER					
DC Characteristics	ONE		.,	\ , , ₁ ,	
Differential Output Voltage	GND		V _{cc}	Volts	Unloaded; R = ∞ ; see figure 1
Differential Output Voltage	2		V _{cc}	Volts	With Load; $R = 50\Omega$; (RS422);
D			.,		see figure 1
Differential Output Voltage	1.5		V _{cc}	Volts	With Load; R = 27Ω ; (RS485);
Observation Managitudes of Debuga					see figure
Change in Magnitude of Driver					
Differential Output Voltage for			0.2	Valta	D = 270 or D = 500; and figure 1
Complimentary States Driver Common-Mode			0.2	Volts	$R = 27\Omega$ or $R = 50\Omega$; see figure 1
Output Voltage			3	Volts	R = 27Ω or R = 50Ω; see figure 1
Input High Voltage	2.0		3	Volts	Applies to D, RE, DE
Input Low Voltage	2.0		0.8	Volts	Applies to D, RE, DE
Input Current			±10		Applies to D, RE, DE
Driver Short-Circuit Current			±10	μΑ	Applies to D, RE, DE
$V_{OUT} = HIGH$			250	mA	-7V ≤ V _o ≤ 12V
$V_{OUT} = LOW$			250	mA	$-7V \le V_0 \le 12V$
V _{OUT} - LOVV			250	111/1	-7 V = V ₀ = 12 V
SP491E DRIVER					
AC Characteristics					
Maximum Data Rate	10			Mbps	RE = 5V, DE = 5V
Driver Input to Output	10	30	60	ns	t · R = 540 C = C = 100nF·
Briver input to Output				110	t_{PLH} ; $R_{DIFF} = 54\Omega$, $C_{L1} = C_{L2} = 100pF$; see figures 3 and 5
Driver Input to Output		30	60	ns	t_{PHL} ; $R_{DIFF} = 54\Omega$, $C_{L1} = C_{L2} = 100pF$;
Zirioi ilipat to Gatpat					see figures 3 and 5
Driver Skew		5	10	ns	see figures 3 and 5.
					$t_{\text{evew}} = t_{\text{DDIAL}} - t_{\text{DDIAL}} $
Driver Rise or Fall Time		15	40	ns	$t_{\text{SKEW}} = t_{\text{DPLH}} - t_{\text{DPHL}} $ From 10% to 90%; $R_{\text{DIFF}} = 54\Omega$,
					C ₁₁ = C ₁₂ = 100pF; see figures 3 and
Driver Enable to Output High		40	70	ns	$C_{11}^{c} = C_{12}^{c} = 100 pF$; see figures
					$C_{L1} = C_{L2} = 100 \text{pF}$; see figures 3 and $C_{L1} = C_{L2} = 100 \text{pF}$; see figures 4 and 6; S_2 closed
Driver Enable to Output Low		40	70	ns	C., = C., = 100pF: see figures
					4 and 6; S₁ closed
Driver Disable Time from Low		40	70	ns	$C_{L1} = C_{L2} = 100 \text{pF}$; see figures
		40	70		4 and 6; S ₁ closed
D : D: 11 =	1	40	70	ns	C = C = 100 pF see figures
Driver Disable Time from High				10	4 1 C C - 1
Driver Disable Time from High					$C_{L_1} = C_{L_2} = 100 \text{pF}$; see figures 4 and 6; S_2 closed

 T_{min} to T_{max} and V_{cc} = 5V ± 5% unless otherwise noted.

PARAMETERS	MIN.	TYP.	MAX.	UNITS	CONDITIONS
SP491E RECEIVER	IVIIIN.	ITP.	IVIAA.	UNITS	CONDITIONS
DC Characteristics					
Differential Input Threshold	-0.2		+0.2	Volts	-7V ≤ V _{CM} ≤ 12V
Input Hysteresis		70		mV	$V_{CM} = 0V$
Output Voltage High	3.5			Volts	$I_0^{CM} = -4\text{mA}, V_{1D} = +200\text{mV}$
Output Voltage Low			0.4	Volts	$I_0^{\circ} = +4 \text{mA}, \ V_{10} = -200 \text{mV}$
Three State (high impedance)					· · · · · · · · · · · · · · · · · · ·
Output Current	1.0		±1	μA	$0.4V \le V_o \le 2.4V$; $\overline{RE} = 5V$
Input Resistance	12	15	.40	kΩ	$-7V \le V_{CM} \le 12V$
Input Current (A, B); V _{IN} = 12V			±1.0 -0.8	mA mA	DE = $0V_{,V_{CC}}^{,W}$ = 0V or 5.25V, $V_{,IN}$ = 12V DE = $0V_{,V_{CC}}$ = 0V or 5.25V, $V_{,IN}$ = -7V
Input Current (A, B); $V_{IN} = -7V$ Short-Circuit Current			-0.6 85	mA	$0V \le V_0 \le V_{CC}$
Short-offcult Guiterit			05	1117	OV = V _O = V _{CC}
SP491E RECEIVER					
AC Characteristics					
Maximum Data Rate	10			Mbps	RE = 0V
Receiver Input to Output	20	45	100	ns	t_{PLH} ; $R_{DIFF} = 54\Omega$,
					$C_{L1}^{FLH} = C_{L2}^{FFF} = 100 \text{pF}$; Figures 3 & 7
Receiver Input to Output	20	45	100	ns	t_{PHL}^{EI} ; $R_{DIFF}^{EE} = 54\Omega$, $C_{L1} = C_{L2}^{E} = 100pF$; Figures 3 & 7
Diff Dessiver Skow It t I		13		200	$C_{L1} = C_{L2}^{-1} 100 \text{pF}$; Figures 3 & 7
Diff. Receiver Skew It _{PLH} -t _{PHL} I		13		ns	$R_{DIFF}^{ET} = 54\Omega; C_{L1} = C_{L2} = 100pF;$ Figures 3 & 7
Receiver Enable to Output Low		45	70	ns	C _{RL} = 15pF; Figures 2 and 8; S ₁ closed
Receiver Enable to Output High		45	70	ns	$C_{\text{Pl}} = 15\text{pF}$; Figures 2 and 8; S_2 closed
Receiver Disable from Low		45	70	ns	C _{Ri} = 15pF; Figures 2 and 8; S ₁ closed
Receiver Disable from High		45	70	ns	C _{RI} = 15pF; Figures 2 and 8; S ₂ closed
					1.02
POWER REQUIREMENTS					
Supply Voltage	+4.75		+5.25	Volts	
Supply Current		900		μA	\overline{RE} , D = 0V or V_{cc} ; DE = V_{cc}
SP491E ENVIRONMENTAL					
AND MECHANICAL					
Operating Temperature					
Commercial (_C_)	0		+70	°C	
Industrial (_E_)	-40		+85	°C	
Storage Temperature Package	-65		+150		
Plastic DIP (P)					
NSOIC (N)					



DESCRIPTION

The **SP490E** and **SP491E** are full-duplex differential transceivers that meet the requirements of RS-485 and RS-422. Fabricated with a **Exar** proprietary BiCMOS process, both products require a fraction of the power of older bipolar designs.

The RS-485 standard is ideal for multi-drop applications or for long-distance interfaces. RS-485 allows up to 32 drivers and 32 receivers to be connected to a data bus, making it an ideal choice for multi-drop applications. Since the cabling can be as long as 4,000 feet, RS-485 transceivers are equipped with a wide (-7V to +12V) common mode range to accommodate ground potential differences. Because RS-485 is a differential interface, data is virtually immune to noise in the transmission line.

Driver...

The drivers for both the **SP490E** and **SP491E** have differential outputs. The typical voltage output swing with no load will be 0 volts to +5 volts. With worst case loading of 54Ω across the differential outputs, the driver can maintain greater than 1.5V voltage levels.

The driver of the **SP491E** has a driver enable control line which is active high. A logic high on DE (pin 4) of the **SP491E** will enable the differential driver outputs. A logic low on DE (pin 4) of the **SP491E** will tri-state the driver outputs. The **SP490E** does not have a driver enable.

Receiver...

The receivers for both the **SP490E** and **SP491E** have differential inputs with an input sensitivity as low as ± 200 mV. Input impedance of the receivers is typically $15k\Omega$ ($12k\Omega$ minimum). A wide common mode range of -7V to +12V allows for large ground potential differences between systems. The receivers for both the **SP490E** and **SP491E** are equipped with the fail-safe feature. Fail-safe guarantees that the receiver output will be in a high state when the input is left unconnected.

The receiver of the **SP491E** has a receiver enable control line which is active low. Alogic low on REB (pin 3) of the **SP491E** will enable the differential receiver. Alogic high on REB (pin 3) of the **SP491E** will tri-state the receiver.

ESD TOLERANCE

The SP490E/SP491E devices incorporates ruggedized ESD cells on all driver output and receiver input pins. The ESD structure is improved over our previous family for more rugged applications and environments sensitive to electro-static discharges and associated transients. The improved ESD tolerance is at least ±15kV without damage nor latch-up.

There are different methods of ESD testing applied:

a) MIL-STD-883, Method 3015.7 b) IEC61000-4-2 Air-Discharge c) IEC61000-4-2 Direct Contact

The Human Body Model has been the generally accepted ESD testing method for semiconductors. This method is also specified in MIL-STD-883, Method 3015.7 for ESD testing. The premise of this ESD test is to simulate the human body's potential to store electro-static energy and discharge it to an integrated circuit. The simulation is performed by using a test model as shown in Figure 9. This method will test the IC's capability to withstand an ESD transient during normal handling such as in manufacturing areas where the ICs tend to be handled frequently.

The IEC-61000-4-2, formerly IEC801-2, is generally used for testing ESD on equipment and systems. For system manufacturers, they must guarantee a certain amount of ESD protection since the system itself is exposed to the outside environment and human presence. The premise with IEC61000-4-2 is that the system is required to withstand an amount of static electricity when ESD is applied to points and surfaces of the equipment that are accessible to personnel during normal usage. The transceiver IC receives most of the ESD current when the ESD source is applied to the connector pins. The test circuit for IEC61000-4-2 is shown on Figure 10. There are two methods within IEC61000-4-2. the Air Discharge method and the Contact Discharge method.

With the Air Discharge Method, an ESD voltage is applied to the equipment under test (EUT) through air. This simulates an electrically charged person ready to connect a cable onto the rear of the system only to find an unpleasant zap just before the person touches the back panel. The high energy potential on the person discharges through an arcing path to the rear panel of the system before he or she even touches the system. This energy, whether discharged directly or through air, is predominantly a function of the discharge current rather than the discharge voltage. Variables with an air discharge such as approach speed of the object carrying the ESD potential to the system and humidity will tend to change the discharge current. For example, the rise time of the discharge current varies with the approach speed.

The Contact Discharge Method applies the ESD current directly to the EUT. This method was devised to reduce the unpredictability of the ESD arc. The discharge current rise time is constant since the energy is directly transferred without the air-gap arc. In situations such as hand held systems, the ESD charge can be directly discharged to the equipment from a person already holding the equipment. The current is transferred on to the keypad or the serial port of the equipment directly and then travels through the PCB and finally to the IC.

The circuit model in Figures 9 and 10 represent the typical ESD testing circuit used for all three methods. The $C_{\rm S}$ is initially charged with the DC power supply when the first switch (SW1) is on. Now that the capacitor is charged, the second switch (SW2) is on while SW1 switches off. The voltage stored in the capacitor is then applied through $R_{\rm S}$, the current limiting resistor, onto the device under test (DUT). In ESD tests, the SW2 switch is pulsed so that the device under test receives a duration of voltage.

For the Human Body Model, the current limiting resistor (R_s) and the source capacitor (C_s) are 1.5k Ω an 100pF, respectively. For IEC-61000-4-2, the current limiting resistor (R_s) and the source capacitor (C_s) are 330 Ω an 150pF, respectively.

The higher C_s value and lower R_s value in the IEC61000-4-2 model are more stringent than the Human Body Model. The larger storage capacitor injects a higher voltage to the test point when SW2 is switched on. The lower current limiting resistor increases the current charge onto the test point.

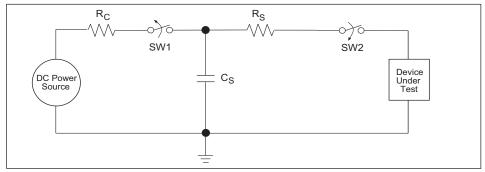


Figure 9. ESD Test Circuit for Human Body Model

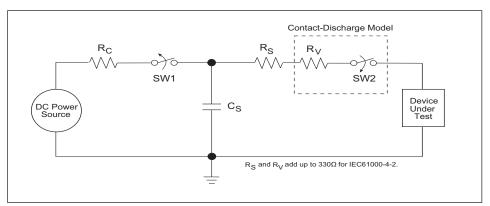


Figure 10. ESD Test Circuit for IEC61000-4-2

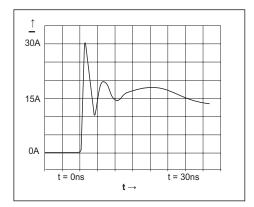
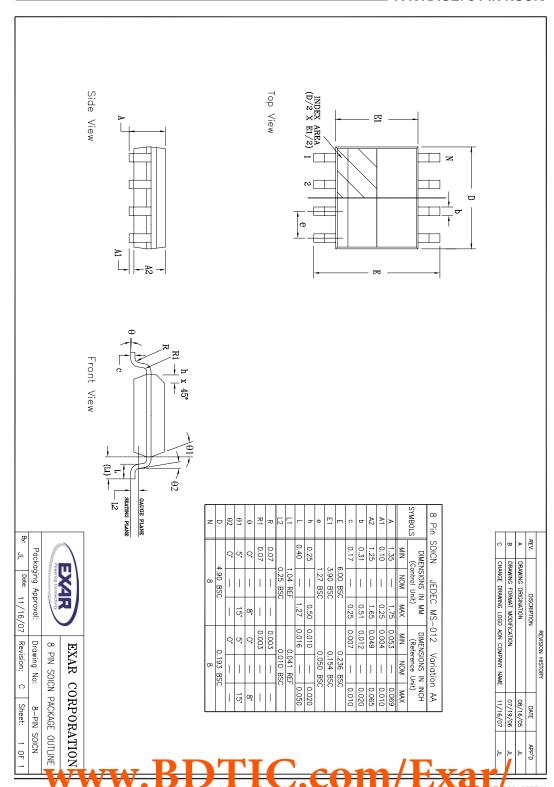
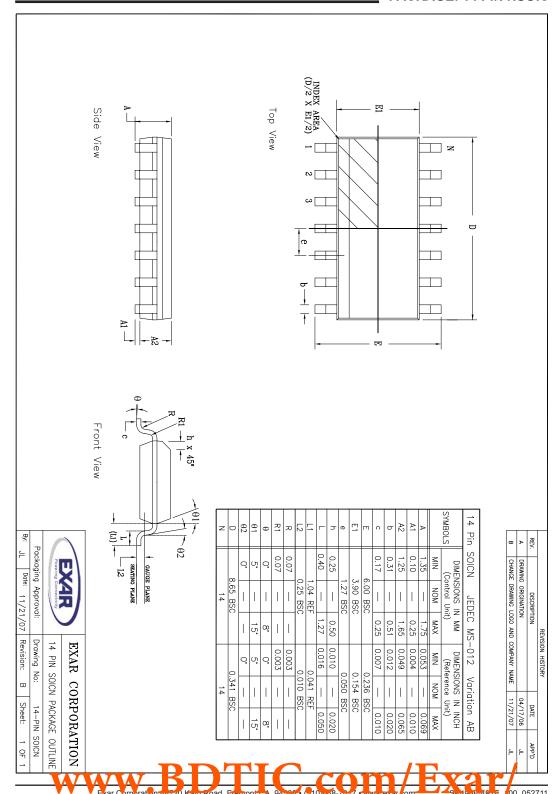


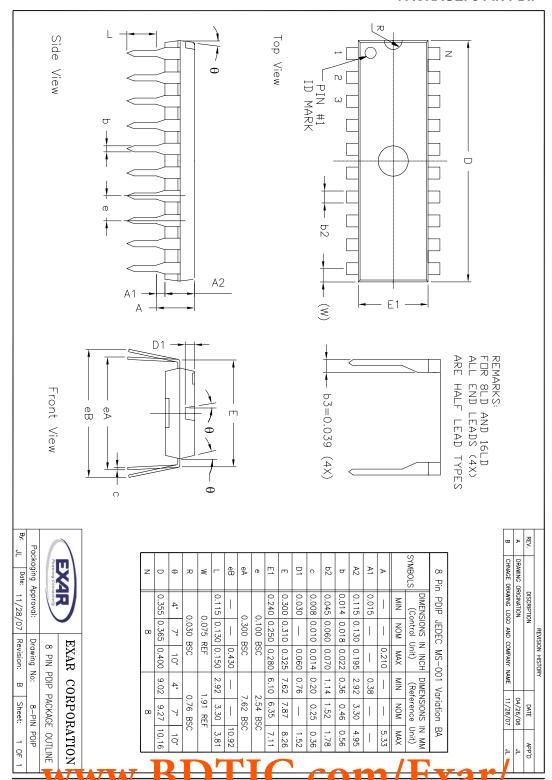
Figure 11. ESD Test Waveform for IEC61000-4-2

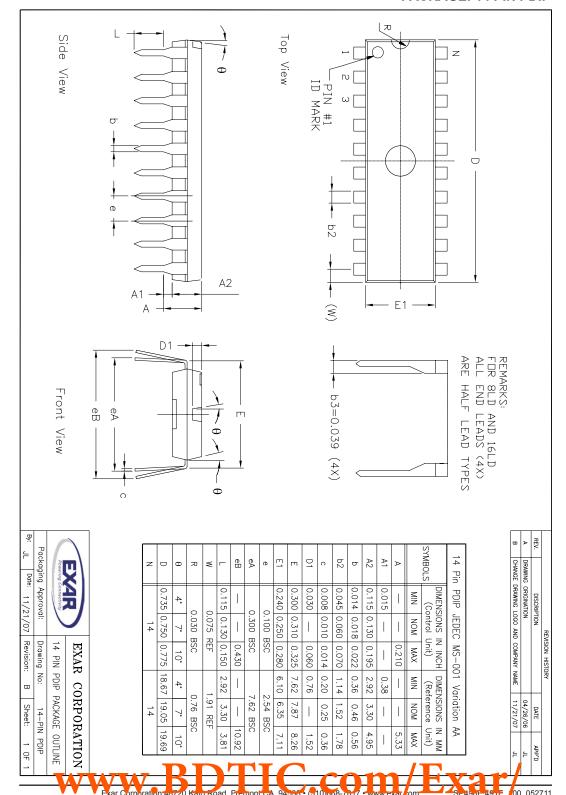
SP490E, SP491E FAMILY	HUMAN BODY MODEL	Air Discharge	IEC61000-4-2 Direct Contact	Level
Driver Outputs	±15kV	±15kV	±8kV	4 4
Receiver Inputs	±15kV	±15kV	±8kV	

Tabke 1. Transceiver ESD Tolerance Levels









ORDERING INFORMATION

Model	Temperature Range	Package
SP490ECN-L	0°C to +70°C	8-Pin NSOIC
SP490ECN-L/TR	0°C to +70°C	8-Pin NSOIC
	0°C to +70°C	
SP490EEN-L	40°C to +85°C	8-Pin NSOIC
	-40°C to +85°C	
SP490EEP-L	40°C to +85°C	8-Pin PDIP
SD401ECN I	0°C to +70°C	14 Pin NSOIC
	0°C to +70°C	
	0°C to +70°C	
	-40°C to +85°C	
	40°C to +85°C	
SP491EEP-L	40°C to +85°C	14-Pin PDIP

Note: /TR = Tape and Reel

REVISION HISTORY

Date	Revision	Description
2000	14	Sipex Legacy Data Sheet
May 2011	1.0.0	Convert to Exar format. Remove driver propagation delay minimum and driver rise/fall time minimum entry for SP490E and SP491E. Update ESD rating to IEC61000-4-2. Update ordering information.

Notice

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Datasheet May 2011

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